



## NPTel ONLINE CERTIFICATION COURSES

# EARTHQUAKE SEISMOLOGY

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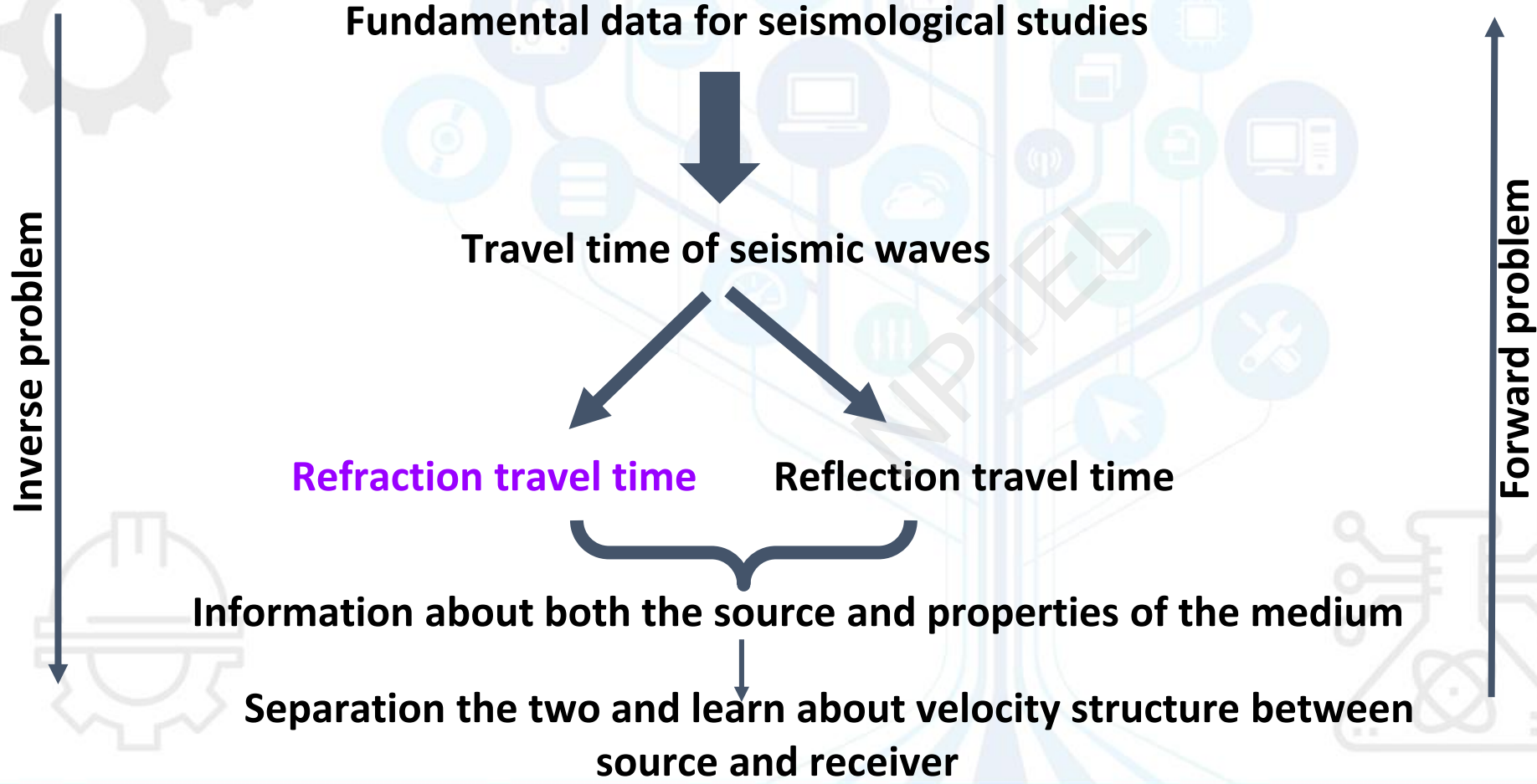
**Module 05 : Refraction and Reflection seismology**

**Lecture 01: Refraction seismology in flat interfaces and limitations**

# CONCEPTS COVERED

- Introduction
- Refraction seismology for flat Earth
- Limitations
- Summary

# Introduction



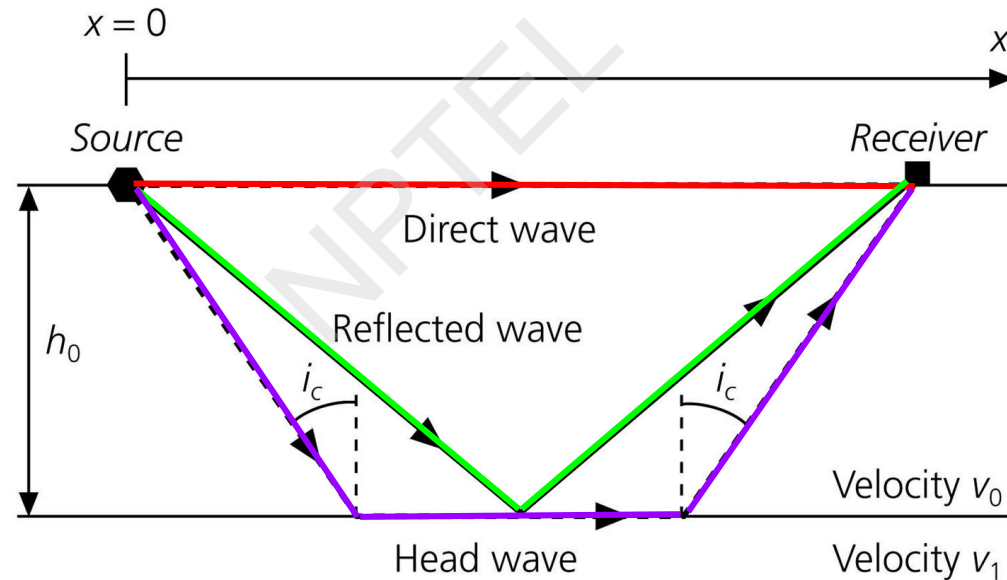
# Introduction

- A major application of seismology is to find the Earth structure, such as the distribution of P- and S-wave velocities and density.
- For this purpose, we record arrival times of refracted waves and reflected waves. These travel times are used to infer about the distribution of seismic velocities, and hence elastic properties, within the earth.
- We do this utilizing the concepts of refraction and reflection seismology.

# Refraction Seismology

- More precisely, Refraction seismology is concerned about the travel time of critically refracted wave at the interface of two medium, to identify the depth of interface, velocity of the layer and underlying half space.

Figure 3.2-1: Ray paths for a layer over a halfspace.



- Governing Principles:

Snell's law

Huygen's principle

Fermat principle.



# Refraction Seismology (The flat layers Earth model)

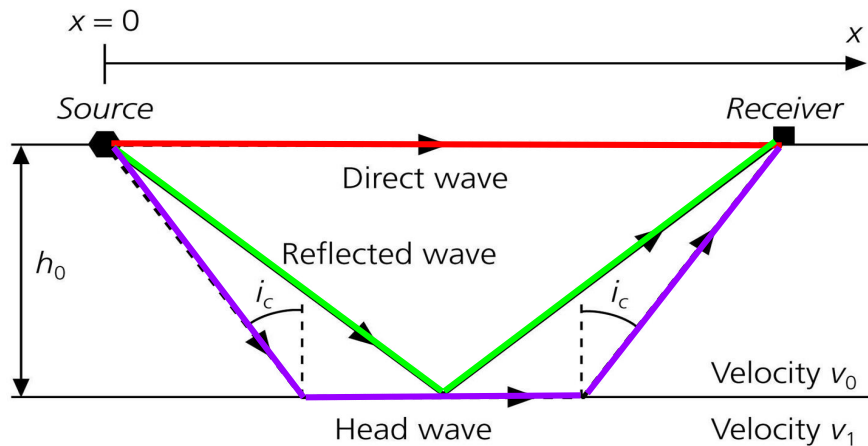
## Direct wave

- Distance between source and receiver is called offset.
- Direct wave ray path is shown in red.

$$T_D = \frac{x}{v_0}$$

(This travel time curve is a linear function of distance, with slope  $1/v_0$  that goes through the origin.)

Figure 3.2-1: Ray paths for a layer over a halfspace.



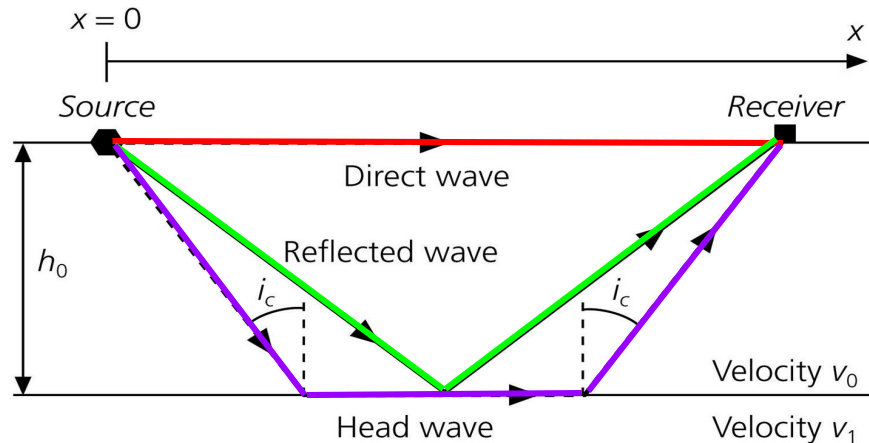
# Refraction Seismology

## Reflected wave

- The second ray path is for a wave reflected (marked as **green**) from the interface. Because the angle of incidence and reflection are equal and the wave reflects halfway between the source and receiver.

$$T_R(x) = 2 \frac{\left( \frac{x^2}{4} + h_0^2 \right)^{\frac{1}{2}}}{v_0} \quad \Rightarrow \quad T_R^2(x) = \frac{x^2}{v_0^2} + 4 \frac{h_0^2}{v_0^2} \quad \text{for } x \gg h$$

Figure 3.2-1: Ray paths for a layer over a halfspace.



- This curve is hyperbola in the t-x plane.
- Reflected wave travel time asymptotically approaches that of direct wave.
- For zero offset (x=0), the reflected wave path is vertical downgoing and upgoing wave with travel time  $T_R(0) = 2 \frac{h_0}{v_0}$

# Refraction Seismology

## Head wave

- The third type of wave is “head wave”, often referred to as refracted wave (marked as **Purple**)

In this case, downgoing wave impinges on the interface at an angle at or beyond the critical angle.

$$T_H(x) = \frac{x - 2h_0 \tan i_c}{v_1} + \frac{2h_0}{v_0 \cos i_c}$$

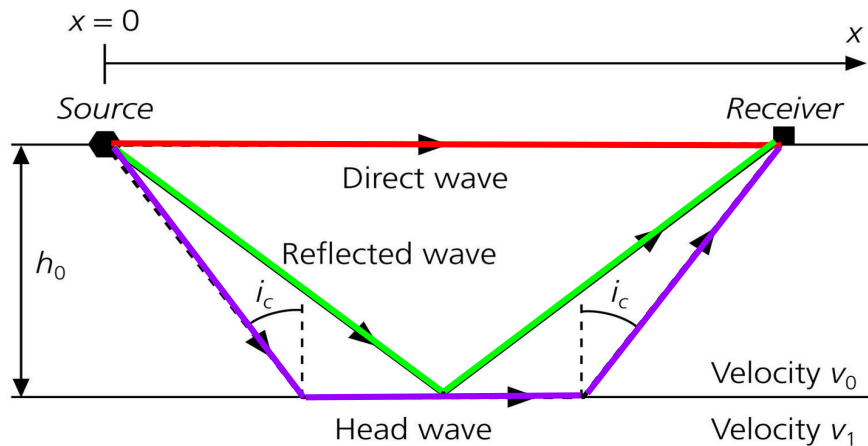
$$= \frac{x}{v_1} + 2h_0 \left( \frac{1}{v_0 \cos i_c} - \frac{\tan i_c}{v_1} \right)$$

$$\text{using } \sin i_c = \frac{v_0}{v_1}$$

To simplify this equation, we use trigonometric identities showing that

$$\cos i_c = (1 - \sin^2 i_c)^{1/2} = \left(1 - \frac{v_0^2}{v_1^2}\right)^{1/2} \quad \tan i_c = \frac{\sin i_c}{\cos i_c} = \frac{v_0/v_1}{(1 - v_0^2/v_1^2)^{1/2}}$$

Figure 3.2-1: Ray paths for a layer over a halfspace.



$$T_H(x) = \frac{x}{v_1} + 2h_0 \left( \frac{1}{v_0^2} - \frac{1}{v_1^2} \right)^{1/2} = \frac{x}{v_1} + \tau_1$$

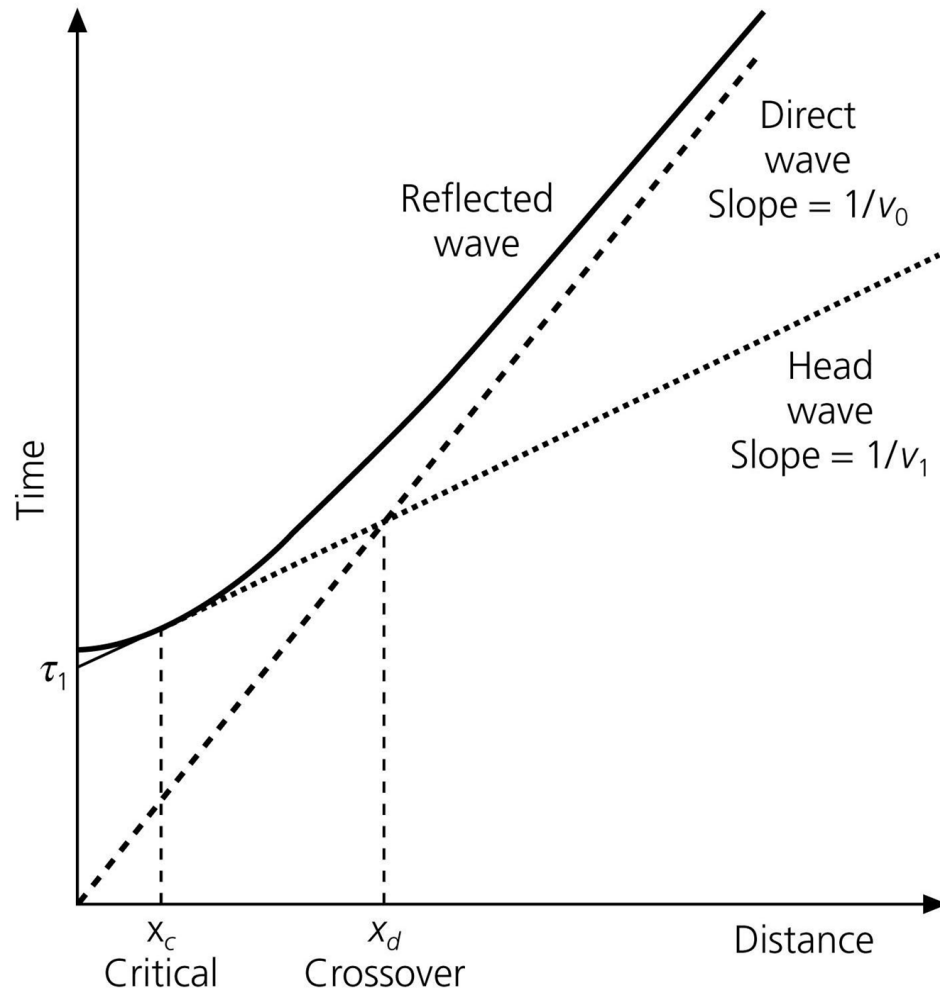


Thus the head wave's travel time curve is a line with a slope of  $1/v_1$  and a time axis intercept of

$$\tau_1 = 2h_o \left( \frac{1}{v_o^2} - \frac{1}{v_1^2} \right)^{1/2} \text{ .....equ. 1}$$

- At some point, however, the travel time curves cross the direct wave, and beyond this point the head wave is the first arrival even though it traveled a longer path. This occurs because it travel with greater speed in the underlying layer.
- **Although the head wave appears only beyond the critical distance,  $x_c = 2h_o \tan i_c$ , where critical incidence first occurs.** This arrival is called head wave because after the crossover distance, it reaches before the direct wave.

Figure 3.2-2: Travel time curve for rays in a layer over a halfspace.



The cross over distance is found by setting  $T_D(x) = T_H(x)$ ,

$$x_d = 2h_o \left( \frac{v_1 + v_o}{v_1 - v_o} \right)^{1/2} \quad \text{.....equ. 2}$$

Hence the crossover distance depends on the velocities of the layer and the half space and the thickness of the layer.

**Note:**

1. Slope of direct wave gives  $v_o$ , velocity of top layer.
1. Slope of head wave gives  $v_1$ , velocity of half space.

## For n-layers

The travel time curve for a head wave at the top of the  $n^{\text{th}}$  layer is a line with slope  $1/v_n$ , that can be extrapolated to its intercept on the  $t$  axis,  $\tau_n$ , and written

$$T_{H_n}(x) = \frac{x}{v_n} + \tau_n$$

where, by analogy to the layer over the half-space case

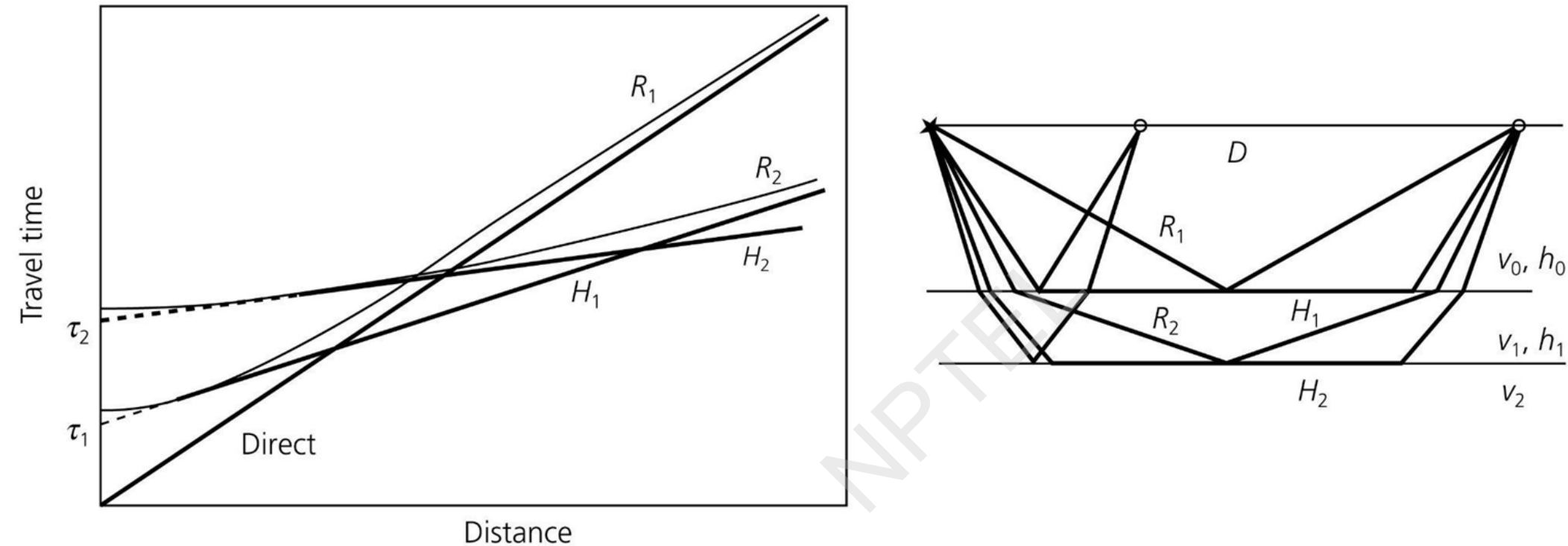
$$\tau_n = 2 \sum_{j=0}^{n-1} h_j \left( \frac{1}{v_j^2} - \frac{1}{v_n^2} \right)^{1/2}$$

The thickness of successive layers can be found by starting with the top layer, whose thickness  $h_0$ , is given by Eqn 1 or 2, and continuing downward using the iterative formula:

$$h_{n-1} = \frac{\tau_n - 2 \sum_{j=0}^{n-2} h_j \left( \frac{1}{v_j^2} - \frac{1}{v_n^2} \right)^{1/2}}{2 \left( \frac{1}{v_{n-1}^2} - \frac{1}{v_n^2} \right)^{1/2}}$$



**Figure 3.2-7: Rays and times for two layers over a halfspace.**



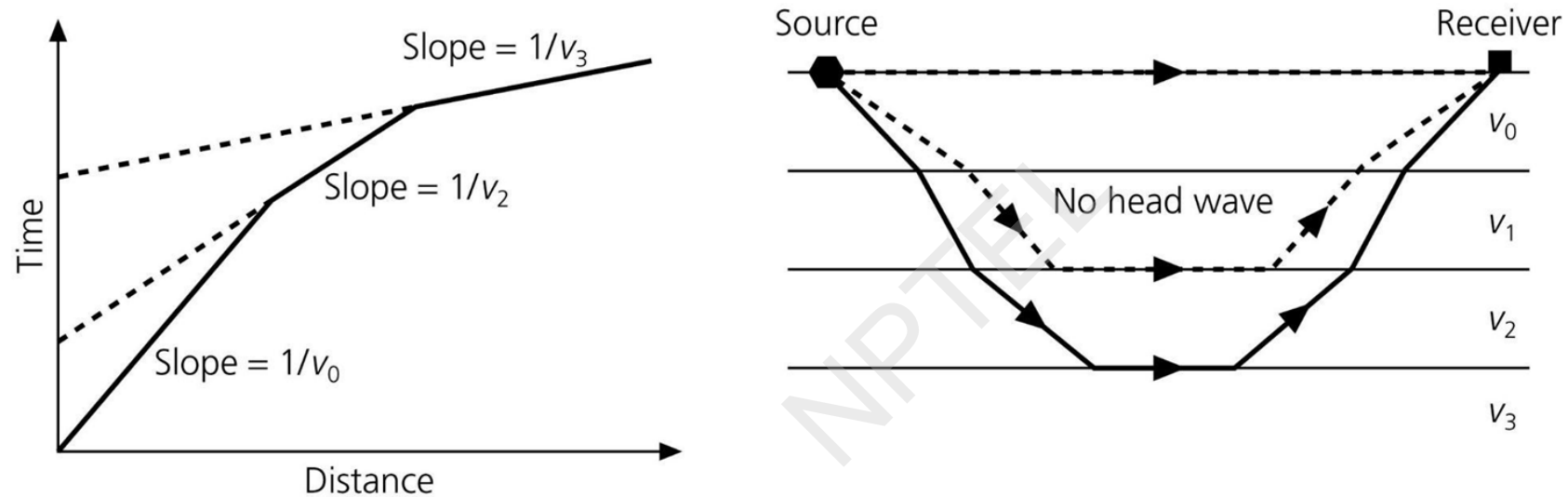
Ray paths and travel times for a multilayered model in which velocity increases with depth. Each layer gives rise to a head wave  $H_i$ , whose intercept on the time axis is  $\tau_i$ , and a reflection  $R_i$ . The direct wave arrival is also shown.



# Limitations

## Case 1: Presence of low velocity zone

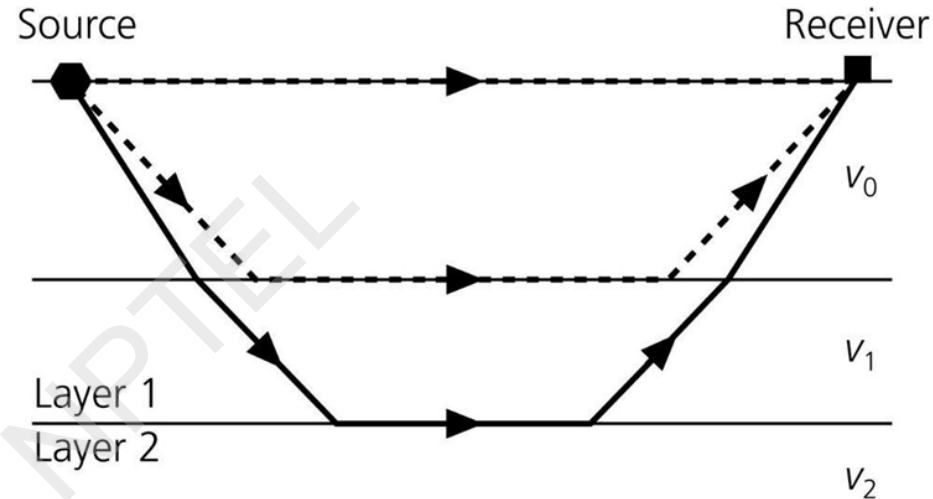
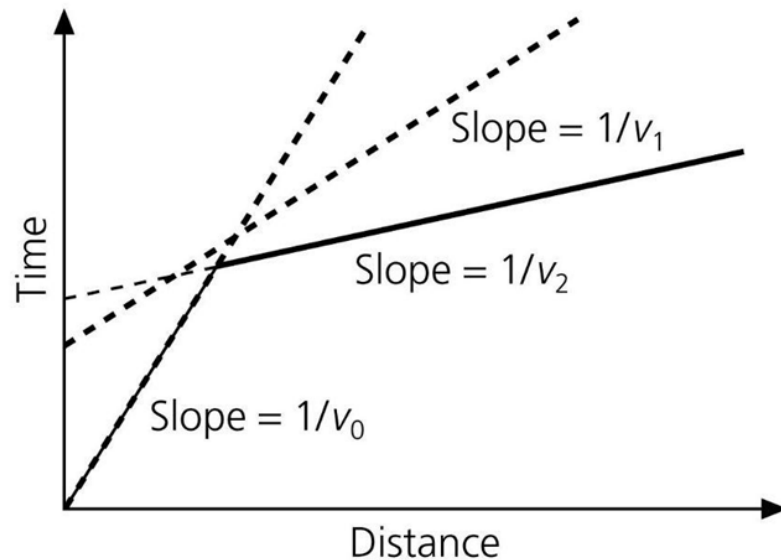
Figure 3.2-8: Rays and times for the case with a low-velocity layer.



Travel time curves, showing first arrivals only, for a model with three layers over a halfspace. Because the middle layer is a low-velocity layer with  $v_1 < v_0$ , no head wave arises at its top.

## Case 2: Layer is too thin or has a small velocity contrast

**Figure 3.2-9: Rays and times for the case of a "blind zone."**



Another possible problem occurs if a layer is thin or has a small velocity contrast with the one below it. Although a head wave results, it may never appear

## Summary

- A major application of seismology is the determination of the distribution of seismic velocities, and hence elastic properties, within the earth.
- Refraction seismology is concerned about the travel time of critically refracted wave at the interface of two medium, to identify the depth of interface, velocity of the layer and underlying half space.
- Travel time as a function of offset  $T_D = x/v_0$

$$T_R^2(x) = \frac{x^2}{v_0^2} + 4 \frac{h_0^2}{v_0^2}$$

$$u = \sqrt{p^2 + \eta^2}$$

$$T_H(x) = \frac{x}{v_1} + 2h_o \left( \frac{1}{v_o^2} - \frac{1}{v_1^2} \right)^{1/2} = \frac{x}{v_1} + \tau_1$$

- The thickness of successive layers can be found by starting with the top layer:

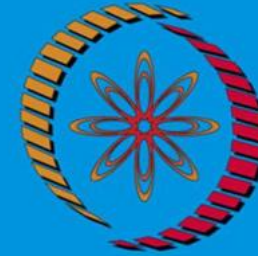
$$h_{n-1} = \frac{\tau_n - 2 \sum_{j=0}^{n-2} h_i \left( \frac{1}{v_j^2} - \frac{1}{v_n^2} \right)^{1/2}}{2 \left( \frac{1}{v_{n-1}^2} - \frac{1}{v_n^2} \right)^{1/2}}$$



# REFERENCES

- Stein, Seth, and Michael Wyession. An introduction to seismology, earthquakes, and earth structure. John Wiley & Sons, 2009.
- Lowrie, William, and Andreas Fichtner. Fundamentals of geophysics. Cambridge university press, 2020.
- Kearey, Philip, Michael Brooks, and Ian Hill. An introduction to geophysical exploration. Vol. 4. John Wiley & Sons, 2002.
- <https://www.wikipedia.org/>
- Seismology course, Professor Derek Schutt, Colorado State Univ., USA.





**THANK  
YOU !**